



High-Accuracy, Wide Common-Mode Range, Bi-Directional CURRENT SHUNT MONITOR Zerø-Drift Series

Check for Samples: INA282, INA283, INA284, INA285, INA286

FEATURES

WIDE COMMON-MODE RANGE: -14V to 80V

OFFSET VOLTAGE: ±20μV

CMRR: 140dBACCURACY:

- ±1.4% Gain Error (Max)

- 0.3μV/°C Offset Drift

0.005%/°C Gain Drift (Max)

AVAILABLE GAINS:

50V/V: INA282100V/V: INA286

200V/V: INA283500V/V: INA2841000V/V: INA285

QUIESCENT CURRENT: 900μA (Max)

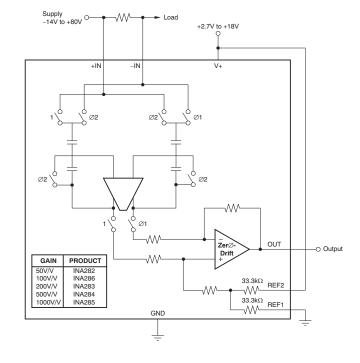
APPLICATIONS

- TELECOM EQUIPMENT
- AUTOMOTIVE
- POWER MANAGEMENT
- SOLAR INVERTERS

DESCRIPTION

The INA282 family, which includes the INA282, INA283, INA284, INA285, and INA286 devices, are voltage output current shunt monitors that can sense drops across shunts at common-mode voltages from –14V to +80V, independent of the supply voltage. The low offset of the Zerø-Drift architecture enables current sensing with maximum drops across the shunt as low as 10mV full-scale.

These current shunt monitors operate from a single +2.7V to +18V supply, drawing a maximum of $900\mu A$ of supply current. They are specified over the extended operating temperature range of $-40^{\circ}C$ to $+125^{\circ}C$, and offered in an SOIC-8 package.



A

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

PACKAGE/ORDERING INFORMATION(1)

PRODUCT	GAIN	PACKAGE	PACKAGE DESIGNATOR	PACKAGE MARKING
INA282	50V/V	SOIC-8	D	I282A
INA283 ⁽²⁾	200V/V	SOIC-8	D	I283A
INA284	500V/V	SOIC-8	D	I284A
INA285	1000V/V	SOIC-8	D	I285A
INA286	100V/V	SOIC-8	D	I286A

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum located at the end of this data sheet, or refer to the device product folder at www.ti.com.

ABSOLUTE MAXIMUM RATINGS(1)

Over operating free-air temperature range, unless otherwise noted.

		INA282, INA283, INA284, INA285, INA286	UNIT
Supply Voltage		+18	V
Analog Inputs,	Differential (V _{+IN}) – (V _{-IN}) ⁽³⁾	-5 to +5	V
$V_{+IN}, V_{-IN}^{(2)}$	Common-Mode	-14 to +80	V
Ref1, Ref2, Out		GND-0.3 to (V+) + 0.3	V
Input Current into	into Any Pin 5		mA
Storage Tempera	ature	-65 to +150	°C
Junction Temper	ature	+150	°C
	Human Body Model (HBM)	3000	V
ESD Ratings:	Charged-Device Model (CDM)	1000	V
	Machine Model (MM)	200	V

⁽¹⁾ Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

THERMAL INFORMATION

	THERMAL METRIC ⁽¹⁾	INA282AID, INA283AID, INA284AID, INA285AID, INA286AID	UNITS
		D	
		8	
θ_{JA}	Junction-to-ambient thermal resistance	134.9	
θ_{JCtop}	Junction-to-case (top) thermal resistance	72.9	
θ_{JB}	Junction-to-board thermal resistance	61.3	°C/W
ΨЈТ	Junction-to-top characterization parameter	18.9	C/VV
ΨЈВ	Junction-to-board characterization parameter	54.3	
θ_{JCbot}	Junction-to-case (bottom) thermal resistance	n/a	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

⁽²⁾ Shaded cells indicate a product preview device.

⁽²⁾ V_{+IN} and V_{-IN} are the voltages at the +IN and -IN pins, respectively.

⁽³⁾ Input voltages must not exceed common-mode rating.



ELECTRICAL CHARACTERISTICS

Boldface limits apply over the specified temperature range, $T_A = -40^{\circ}\text{C}$ to +125°C. At $T_A = +25^{\circ}\text{C}$, $V_{+1N} = 12\text{V}$, $V_{REF1} = V_{REF2} = 2.048\text{V}$ referenced to GND, and $V_{SENSE} = V_{+1N} - V_{-1N}$, unless otherwise

			INA	INA282, INA283 A284, INA285, IN			
PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT	
INPUT							
Offset Voltage, RTI ⁽¹⁾	V _{OS}	V _{SENSE} = 0mV		±20	±70	μV	
vs Temperature	dV _{os} /dT			±0.3	±1.5	μ V/°C	
vs Power Supply	PSRR	$V_S = +2.7V$ to +18V, $V_{SENSE} = 0$ mV		3		μV/V	
Common-Mode Input Range	V _{CM}		-14		80	٧	
Common-Mode Rejection	CMRR	V _{+IN} = -14V to +80V, V _{SENSE} = 0mV	120	140		dB	
Input Bias Current per Pin (2)	I_{B}	V _{SENSE} = 0mV		25		μА	
Input Offset Current	los	V _{SENSE} = 0mV		1		μА	
Differential Input Impedance				6		kΩ	
REFERENCE INPUTS							
Reference Input Gain				1		V/V	
Reference Input Voltage Range ⁽³⁾			0		V _{GND} + 9	V	
Divider Accuracy ⁽⁴⁾				±0.2	±0.5	%	
Reference Voltage Rejection Ratio		V _{REF} 1 = V _{REF} 2 = 40mV to 9V, V+ = 18V					
INA282				±25	±75	μV/V	
vs Temperature				0.055		μ V/V/°C	
INA283				±13	±30	μV/V	
vs Temperature				0.040		μ V/V/°C	
INA284				±6	±25	μV/V	
vs Temperature				0.015		μ V/V/°C	
INA285				±4	±10	μV/V	
vs Temperature				0.010		μ V/V/°C	
INA286				±17	±45	μV/V	
vs Temperature				0.040		μ V/V/°C	
GAIN ⁽⁵⁾		GND + $0.5V \le V_{OUT} \le (V+) - 0.5V$; $V_{REF1} = V_{REF2} = (V+)/2$ for all devices					
Gain	G						
INA282		V+ = +5V		50		V/V	
INA283		V+ = +5V		200		V/V	
INA284		V+ = +12V		500		V/V	
INA285		V+ = +12V		1000		V/V	
INA286		V+ = +5V		100		V/V	
Gain Error							
INA282, INA283, INA286				±0.4	±1.4	%	
INA284, INA285				±0.4	±1.5	%	
vs Temperature				0.0008	0.005	%/°C	
ОИТРИТ							
Nonlinearity Error				±0.01		%	
Output Impedance				1.5		Ω	
Maximum Capacitive Load		No sustained oscillation		1		nF	

- (1) RTI = referred-to-input.
- See typical characteristic graph Figure 20.
- (3) The average of the voltage on pins REF1 and REF2 must be between V_{GND} and the lesser of (V_{GND}+9V) and V+.
 (4) Reference divider accuracy specifies the match between the reference divider resistors using the configuration in Figure 37.
- See typical characteristic graph Figure 25.



Boldface limits apply over the specified temperature range, $T_A = -40^{\circ}\text{C}$ to +125°C. At $T_A = +25^{\circ}\text{C}$, $V_{+} = 5\text{V}$, $V_{+} = 12\text{V}$, $V_{REF1} = V_{REF2} = 2.048\text{V}$ referenced to GND, and $V_{SENSE} = V_{+} =$

		IN	INA282, INA283, A284, INA285, INA		
PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
VOLTAGE OUTPUT ⁽⁶⁾	$R_L = 10k\Omega$ to GND				
Swing to V+ Power-Supply Rail	V+ = 5V		(V+)-0.17	(V+)-0.4	٧
Swing to GND			GND+0.015	GND+0.04	V
FREQUENCY RESPONSE					
Effective Bandwidth ⁽⁷⁾ BW					
INA282			10		kHz
INA283			10		kHz
INA284			4		kHz
INA285			2		kHz
INA286			10		kHz
NOISE, RTI ⁽⁸⁾					
Voltage Noise Density	1kHz		110		nV/√Hz
POWER SUPPLY		·			
Specified Voltage Range V _S		+2.7		+18	V
Quiescent Current I _Q			600	900	μΑ
TEMPERATURE RANGE	_				
Specified Range		-40		+125	°C

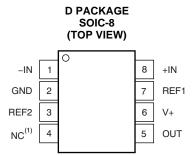
See typical characteristic graphs Figure 29 through Figure 31.

See typical characteristic graph Figure 15 and the Effective Bandwidth section in the Applications Information.

RTI = referred-to-input.



PIN CONFIGURATION



(1) NC: This pin is not internally connected. The NC pin should either be left floating or connected to GND.

PIN DESCRIPTIONS

SOIC-8		
PIN NO.	NAME	DESCRIPTION
1	-IN	Connection to negative side of shunt resistor.
2	GND	Ground
3	REF2	Reference voltage connection - See application section for connection options.
4	NC	This pin is not internally connected. The NC pin should either be left floating or connected to GND.
5	OUT	Output voltage
6	V+	Power supply
7	REF1	Reference voltage connection - See application section for connection options.
8	+IN	Connection to positive side of shunt resistor.



TYPICAL CHARACTERISTICS

At $T_A = +25$ °C, $V_{+} = 5V$, $V_{+IN} = 12V$, $V_{REF1} = V_{REF2} = 2.048V$ referenced to GND, and $V_{SENSE} = V_{+IN} - V_{-IN}$, unless otherwise noted.

START-UP TRANSIENT RESPONSE

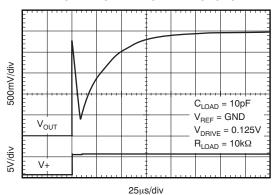


Figure 1.

START-UP TRANSIENT RESPONSE

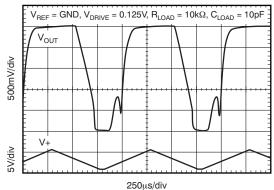


Figure 2.

12V COMMON-MODE STEP RESPONSE

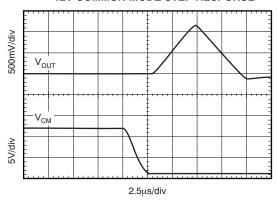


Figure 3.

12V COMMON-MODE STEP RESPONSE

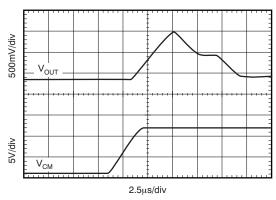


Figure 4.

12V COMMON-MODE STEP RESPONSE

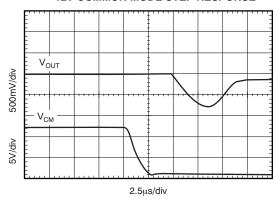


Figure 5.

12V COMMON-MODE STEP RESPONSE

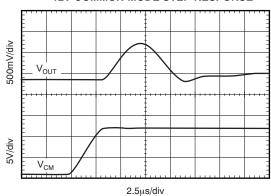
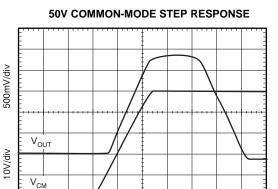


Figure 6.





5μs/div **Figure 7.**

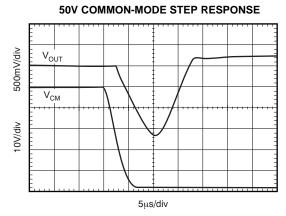


Figure 8.

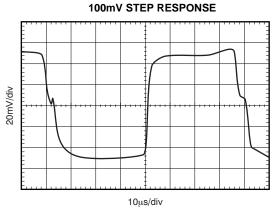


Figure 9.

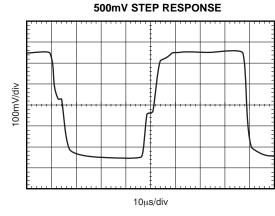


Figure 10.

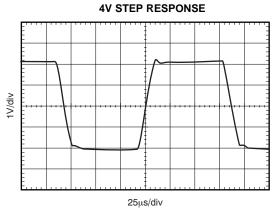


Figure 11.

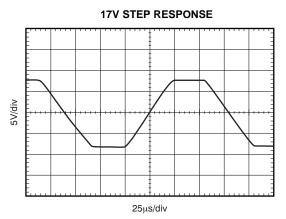


Figure 12.



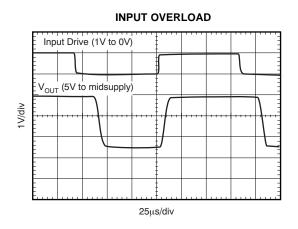


Figure 13.

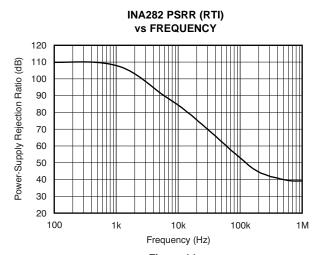


Figure 14.

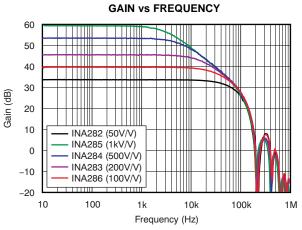


Figure 15.

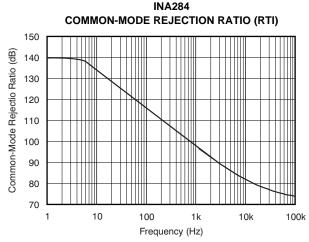


Figure 16.

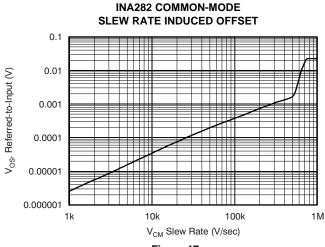


Figure 17.

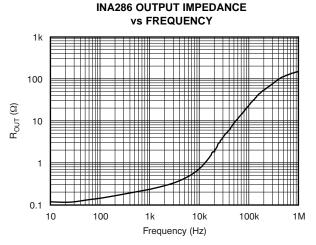
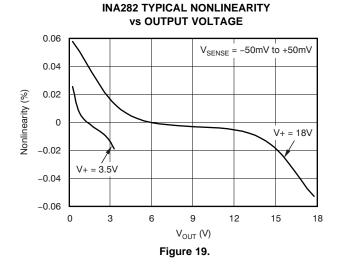
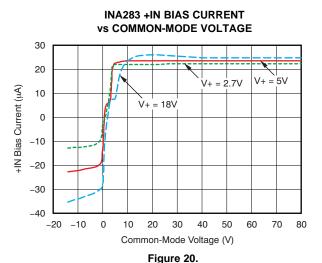
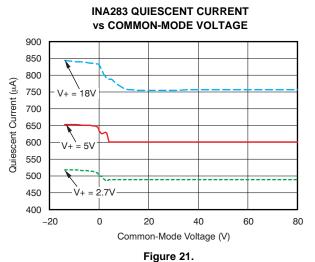


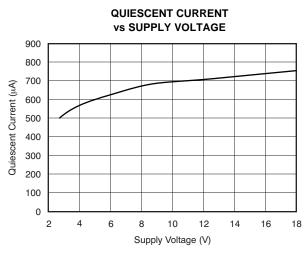
Figure 18.





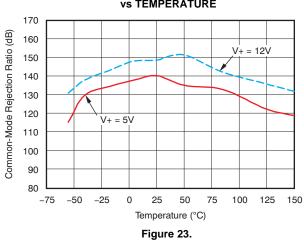












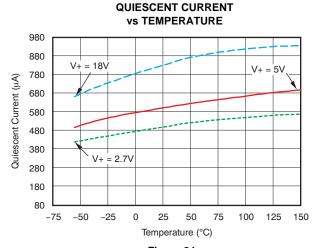


Figure 24.



V + = 2.7V

125

150

V+ = 5V

TYPICAL CHARACTERISTICS (continued)

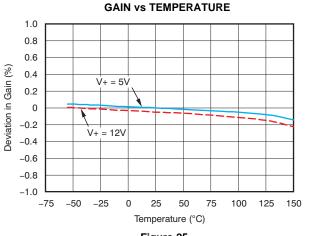
0

-5

-10

-15

At $T_A = +25^{\circ}C$, $V_{+} = 5V$, $V_{+IN} = 12V$, $V_{REF1} = V_{REF2} = 2.048V$ referenced to GND, and $V_{SENSE} = V_{+IN} - V_{-IN}$, unless otherwise noted.



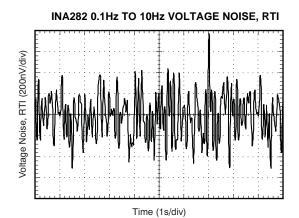
+IN Bias Current (µA) -20 -25 V+ = 18V -30 -35 $V_{CM} = 0V$ -40 -50 -25 0 25 50 75 100 -75

Figure 25.

Temperature (°C) Figure 26.

+IN BIAS CURRENT

vs TEMPERATURE



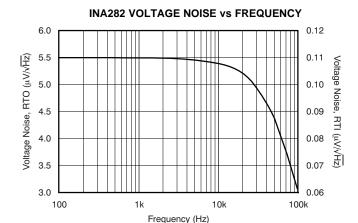
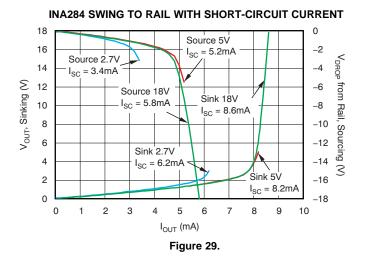


Figure 27.

Figure 28.



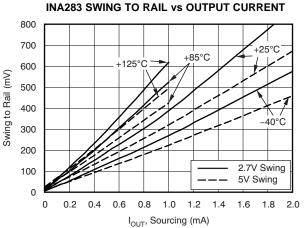
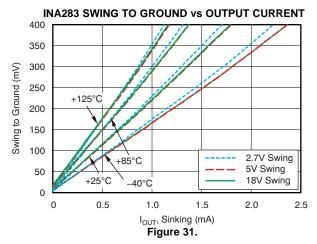


Figure 30.







APPLICATIONS INFORMATION

GENERAL INFORMATION

The INA282 family voltage output current shunt monitors feature a common-mode range that extends 14V below the negative supply rail, as well as up to 80V, which allows use for either low-side or high-side current sensing.

BASIC CONNECTIONS

Figure 32 shows the basic connection of an INA282 family device. The input pins, +IN and -IN, should be connected as closely as possible to the shunt resistor to minimize any resistance in series with the shunt resistance.

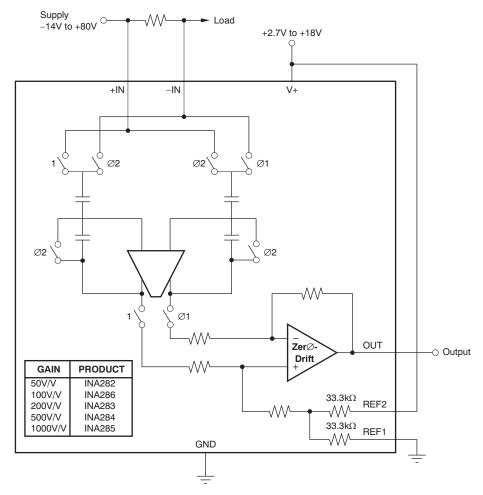


Figure 32. Typical Application

Power-supply bypass capacitors are required for stability. Applications with noisy or high-impedance power supplies may require additional decoupling capacitors to reject power-supply noise. Connect bypass capacitors close to the device pins.



POWER SUPPLY

The INA282 family can make accurate measurements well outside of its own power-supply voltage, V+, because its inputs (+IN and -IN) may operate anywhere between -14V and +80V independent of V+. For example, the V+ power supply can be 5V while the common-mode voltage being monitored by the shunt may be as high as +80V. Of course, the output voltage range of the INA282 family is constrained by the supply voltage that powers it on V+. Note that when the power to the INA282 family is off (that is, no voltage is supplied to the V+ pin), the input pins (+IN and -IN) are high impedance with respect to ground and typically leak less than $\pm 1\mu$ A over the full common-mode range of -14V to +80V

SELECTING Rs

The Zerø-Drift architecture of the INA282 family enables use with full-scale range shunt voltages as low as 10mV.

EFFECTIVE BANDWIDTH

The extremely high dc CMRR of the INA282 family results from the switched capacitor input structure. Because of this architecture, the INA28x exhibits discrete time system behaviors as illustrated in the gain versus frequency graph of Figure 16 and the step response curves of Figure 3 through Figure 10. The response to a step input depends somewhat on the phase of the internal INA28x clock when the input step occurs. It is possible to overload the input amplifier with a rapid change in input common-mode voltage (see Figure 17). Errors as a result of common-mode voltage steps and/or overload situations typically disappear within $15\mu s$ after the disturbance is removed.

TRANSIENT PROTECTION

The -14V to +80V common-mode range of the INA282 family is ideal for withstanding automotive fault conditions that range from 12V battery reversal up to +80V transients; no additional protective components are needed up to those levels. In the event that the INA282 family is exposed to transients on the inputs in excess of its ratings, then external transient absorption with semiconductor transient absorbers (Zener or *Transzorbs*) will be necessary. Use of MOVs or VDRs is not recommended except when they are used in addition to a semiconductor transient absorber. Select the transient absorber such that it cannot allow the INA282 family to be exposed to transients greater than 80V (that is, allow for transient absorber tolerance, as well as additional voltage as a result of transient absorber dynamic impedance). Despite the use of internal zener-type electrostatic discharge (ESD) protection, the INA282 family does not lend itself to using external resistors in series with the inputs without degrading gain accuracy.

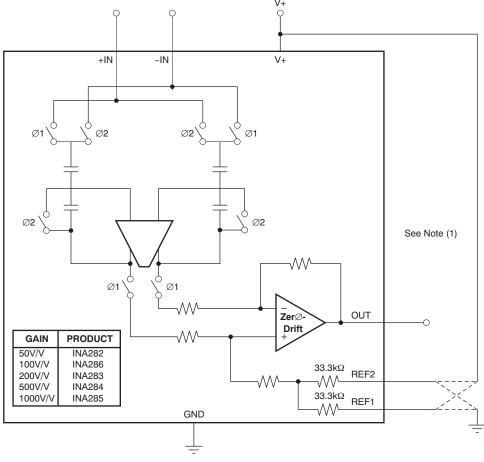
SHUTDOWN

While the INA282 family does not provide a shutdown pin, the quiescent current of 600μA enables it to be powered from the output of a logic gate. Take the gate low to shut down the INA282 family devices.



REFERENCE PIN CONNECTION OPTIONS

Figure 33 illustrates a test circuit for reference divider accuracy. The output of the INA282 family can be connected for unidirectional or bidirectional operation. Note that neither the REF1 pin nor the REF2 pin may be connected to any voltage source lower than GND or higher than V+, and that the effective reference voltage (REF1 + REF2)/2 must be 9V or less. This parameter means that the V+ reference output connection shown in Figure 35 is not allowed for V+ greater than 9V. However, the split-supply reference connection shown in Figure 37 is allowed for all values of V+ up to 18V.



(1) Reference divider accuracy is determined by measuring the output with the reference voltage applied to alternate reference resistors, and calculating a result such that the amplifier offset is cancelled in the final measurement.

Figure 33. Test Circuit for Reference Divider Accuracy



UNIDIRECTIONAL OPERATION

Unidirectional operation allows the INA282 family to measure currents through a resistive shunt in one direction. In the case of unidirectional operation, the output could be set at the negative rail (near ground, and the most common connection) or at the positive rail (near V+) when the differential input is 0V. The output moves to the opposite rail when a correct polarity differential input voltage is applied.

The required polarity of the differential input depends on the output voltage setting. If the output is set at the positive rail, the input polarity must be negative to move the output down. If the output is set at ground, the polarity is positive to move the output up.

The following sections describe how to configure the output for unidirectional operation.

Ground Referenced Output

When using the INA282 family in this mode, both reference inputs are connected to ground; this configuration takes the output to the negative rail when there is 0V differential at the input (as Figure 34 shows).

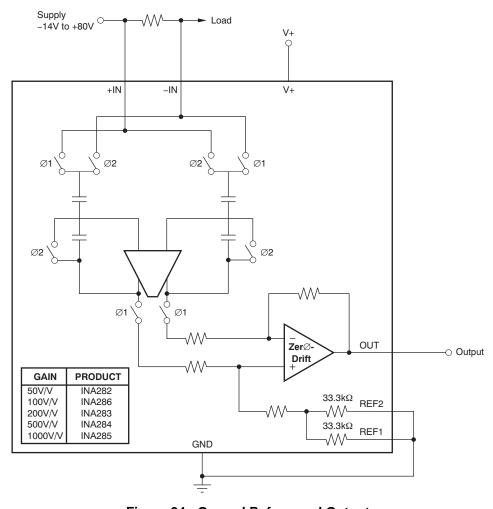


Figure 34. Ground Referenced Output



V+ Referenced Output

This mode is set when both reference pins are connected to the positive supply. It is typically used when a diagnostic scheme requires detection of the amplifier and the wiring before power is applied to the load (as shown in Figure 35).

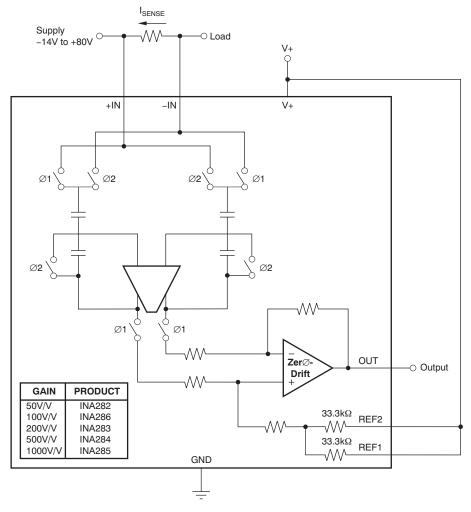


Figure 35. V+ Referenced Output



BIDIRECTIONAL OPERATION

Bidirectional operation allows the INA282 family to measure currents through a resistive shunt in two directions. In this case, the output can be set anywhere within the limits of what the reference inputs allow (that is, between 0V to 9V, but never to exceed the supply voltage). Typically, it is set at half-scale for equal range in both directions. In some cases, however, it is set at a voltage other than half-scale when the bidirectional current is nonsymmetrical.

The quiescent output voltage is set by applying voltage(s) to the reference inputs. REF1 and REF2 are connected to internal resistors that connect to an internal offset node. There is no operational difference between the pins.

External Reference Output

Connecting both pins together and to a reference produces an output at the reference voltage when there is no differential input; this configuration is illustrated in Figure 36. The output moves down from the reference voltage when the input is negative relative to the –IN pin and up when the input is positive relative to the –IN pin. Note that this technique is the most accurate way to bias the output to a precise voltage.

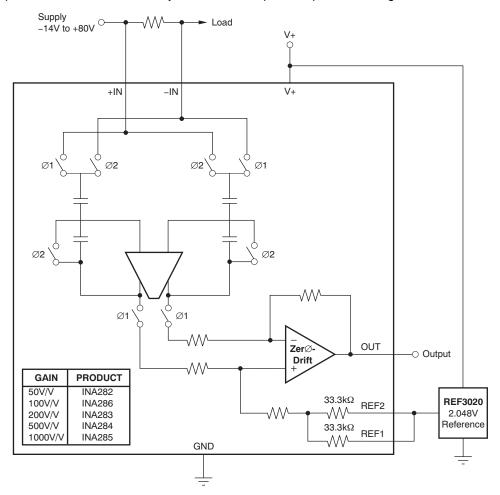


Figure 36. External Reference Output



Splitting the Supply

By connecting one reference pin to V+ and the other to the ground pin, the output is set at half of the supply when there is no differential input, as shown in Figure 37. This method creates a midscale offset that is ratiometric to the supply voltage; thus, if the supply increases or decreases, the output remains at half the supply.

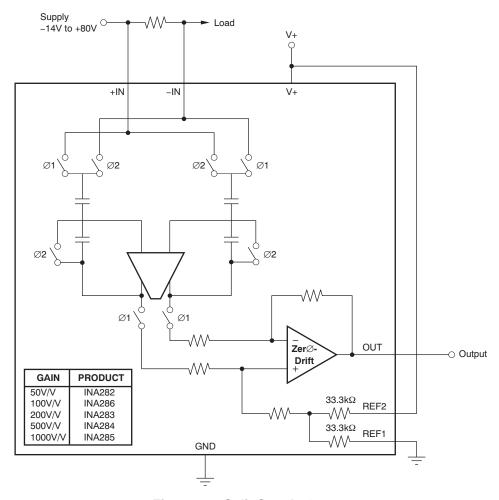


Figure 37. Split-Supply Output



Splitting an External Reference

In this case, an external reference is divided by 2 with an accuracy of approximately 0.5% by connecting one REF pin to ground and the other REF pin to the reference (as Figure 38 illustrates).

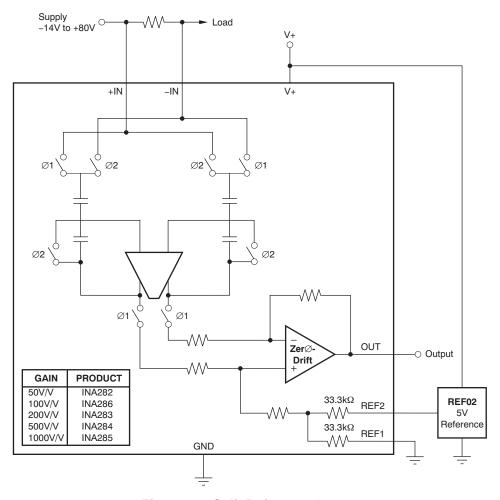


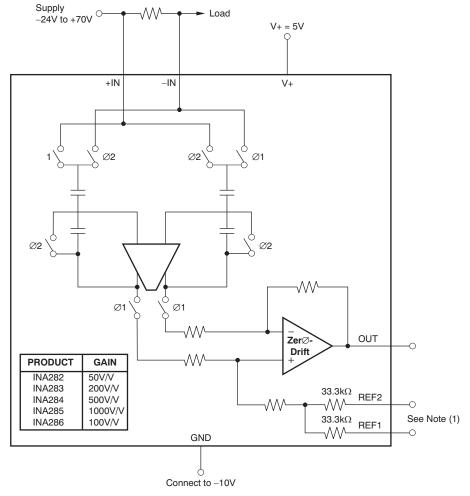
Figure 38. Split Reference Output



EXTENDED NEGATIVE COMMON-MODE RANGE

Using a negative power supply can extend the common-mode range 14V more negative than the supply used. For instance, a -10V supply allows up to -24V negative common-mode. Remember to keep the total voltage between the GND pin and V+ pin to less than 18V. The positive common-mode decreases by the same amount.

The reference input simplifies this type of operation because the output quiescent bias point is always based on the reference connections. Figure 39 shows a circuit configuration for common-mode ranges from –24V to +70V.



(1) Connect the REF pins as desired; however, they cannot exceed 9V above the GND pin voltage.

Figure 39. Circuit Configuration for Common-Mode Ranges from -24V to +70V

CALCULATING TOTAL ERROR

The electrical specifications for the INA282-286 family of devices include the typical individual errors terms such as gain error, offset error, and nonlinearity error. Total error including all of these individual error components is not specified in the Electrical Characteristics table. In order to accurately calculate the error that can be expected from the device, we must first know the operating conditions to which the device is subjected. Some current shunt monitors specify a total error in the product data sheet. However, this total error term is accurate under only one particular set of operating conditions. Specifying the total error at this one point has little practical value because any deviation from these specific operating conditions no longer yields the same total error value. This section discusses the individual error sources, with information on how to apply them in order to calculate the total error value for the device under any normal operating conditions.

The typical error sources that have the largest impact on the total error of the device are input offset voltage, common-mode voltage rejection, gain error and nonlinearity error. For the INA282-286, an additional error source referred to as *Reference Common-Mode Rejection* is also included in the total error value.



The nonlinearity error of the INA282-286 is relatively low compared to the gain error specification, which results in a gain error that can be expected to be relatively constant throughout the linear input range of the device. While the gain error remains constant across the linear input range of the device, the error associated with the input offset voltage does not. As the differential input voltage developed across a shunt resistor at the input of the INA282-286 decreases, the inherent input offset voltage of the device becomes a larger percentage of the measured input signal resulting in an increase in error in the measurement. This varying error is present among all current shunt monitors, given the input offset voltage ratio to the voltage being sensed by the device. The relatively low input offset voltages present in the INA282-286 devices limit the amount of contribution the offset voltage has on the total error term.

The term *Reference Common-Mode Rejection* refers to the amount of error induced by applying a reference voltage to the INA282-286 device that deviates from the inherent bias voltage present at the output of the first stage of the device. The output of the switched-capacitor network and first-stage amplifier has an inherent bias voltage of approximately 2.048V. Applying a reference voltage of 2.048V to the INA282-286 reference pins results in no additional error term contribution. Applying a voltage to the reference pins that differs from 2.048V creates a voltage potential in the internal difference amplifier, resulting in additional current flowing through the resistor network. As a result of resistor tolerances, this additional current flow causes additional error at the output because of resistor mismatches. Additionally, as a result of resistor tolerances, this additional current flow causes additional error at the output based on the common-mode rejection ratio of the output stage amplifier. This error term is referred back to the input of the device as additional input offset voltage. Increasing the difference between the 2.048V internal bias and the external reference voltage results in a higher input offset voltage. Also, as the error at the output is referred back to the input, there is a larger impact on the input-referred offset, V_{OS}, for the lower-gain versions of the device.

Two examples are provided that detail how different operating conditions can affect the total error calculations. Typical and maximum calculations are shown as well to provide the user more information on how much error variance could be present from device to device.

Example 1

INA282; $V_S = 5V$; $V_{CM} = 12V$; $V_{REF} = 2.048V$; $V_{SENSE} = 10mV$

Table 1. Example 1

TERM	SYMBOL	EQUATION	TYPICAL VALUE	MAXIMUM VALUE
Initial Input Offset Voltage	Vos	_	20μV	70μV
Added Input Offset Voltage Because of Common-Mode Voltage	V _{OS_CM}	$\frac{1}{10^{\left(\frac{\text{CMRR_dB}}{20}\right)}} \times (V_{\text{CM}} - 12V)$	$0\mu V$	0μV
Added Input Offset Voltage Because of Reference Voltage	V _{OS_REF}	$R_{CMR} \times (2.048V - V_{REF})$	0μV	0μV
Total Input Offset Voltage	V _{OS_Total}	$\sqrt{(V_{OS})^2 + (V_{OS_CM})^2 + (V_{OS_REF})^2}$	20μV	70μV
Error from Input Offset Voltage	Error_V _{OS}	$\frac{V_{OS_Total}}{V_{SENSE}} \times 100$	0.20%	0.70%
Gain Error	Error_Gain	_	0.40%	1.40%
Nonlinearity Error	Error_Lin	_	0.01%	0.01%
Total Error	_	$\sqrt{(\text{Error}_V_{OS})^2 + (\text{Error}_Gain)^2 + (\text{Error}_Lin)^2}$	0.45%	1.56%



Example 2

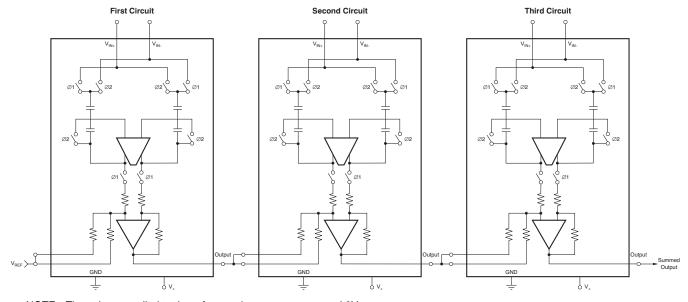
INA286; $V_S = 5V$; $V_{CM} = 24V$; $V_{REF} = 0V$; $V_{SENSE} = 10mV$

Table 2. Example 2

TERM	SYMBOL	EQUATION	TYPICAL VALUE	MAXIMUM VALUE
Initial Input Offset Voltage	V _{OS}	_	20μV	70μV
Added Input Offset Voltage Because of Common-Mode Voltage	V _{OS_CM}	$\frac{1}{10^{\left(\frac{\text{CMRR_dB}}{20}\right)}} \times (V_{\text{CM}} - 12V)$	1.2μV	12μV
Added Input Offset Voltage Because of Reference Voltage	V_{OS_REF}	$R_{CMR} \times (2.048V - V_{REF})$	34.8μV	92.2μV
Total Input Offset Voltage	V _{OS_Total}	$\sqrt{(V_{OS})^2 + (V_{OS_CM})^2 + (V_{OS_REF})^2}$	40.2μV	116.4μV
Error from Input Offset Voltage	Error_V _{OS}	$\frac{V_{OS_Total}}{V_{SENSE}} \times 100$	0.40%	1.16%
Gain Error	Error_Gain	_	0.40%	1.40%
Nonlinearity Error	Error_Lin	_	0.01%	0.01%
Total Error	_	$\sqrt{(\text{Error}_V_{OS})^2 + (\text{Error}_Gain)^2 + (\text{Error}_Lin)^2}$	0.57%	1.82%

SUMMING CURRENTS AND PARALLELING

The outputs of multiple INA282 family devices are easily summed by connecting the output of one INA282 family device to the reference input of a second INA282 family device. Summing beyond two devices is possible by repeating this connection, and is shown for three devices in Figure 40. The reference input of the first INA282 family device sets the output quiescent level for all the devices in the string.



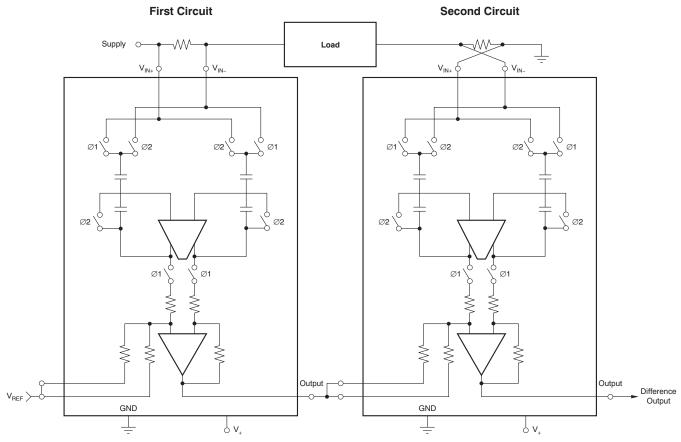
NOTE: The voltage applied to the reference inputs cannot exceed 9V.

Figure 40. Summing the Outputs of Multiple INA282 Family Devices



CURRENT DIFFERENCING

Occasionally, the need arises to confirm that the current into a load is identical to the current out of a load, usually as part of diagnostic testing or fault detection. This situation requires precision current differencing, which is the same as summing except that the two amplifiers have the inputs connected opposite of each other. Under normal operating conditions, the final output is very close to the reference value and proportional to any current difference. Figure 41 is an example of the connections required for current differencing.



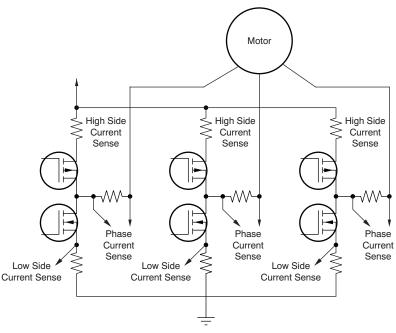
NOTE: This example is identical to the current summing example, except that the two shunt inputs are reversed in polarity, this current differencing circuit is useful in detecting when current into and out of a load do not match.

Figure 41. Current Differencing Using an INA282 Family Device



COMMON-MODE DYNAMICS AND CURRENT DIFFERENCING

Current sensing is frequently used on totem-pole output stages, such as those of bridge-type motor drives. We can sense current in one of three locations on a totem-pole output: on the ground side (low-side sensing); on the power-supply side (high-side sensing); or on the output (phase sensing). Only the output line reports the exact load current. Obviously, the ground and supply-side sensing report only the current in the individual respective phases. Figure 42 depicts these various methods on a three-phase motor driver.

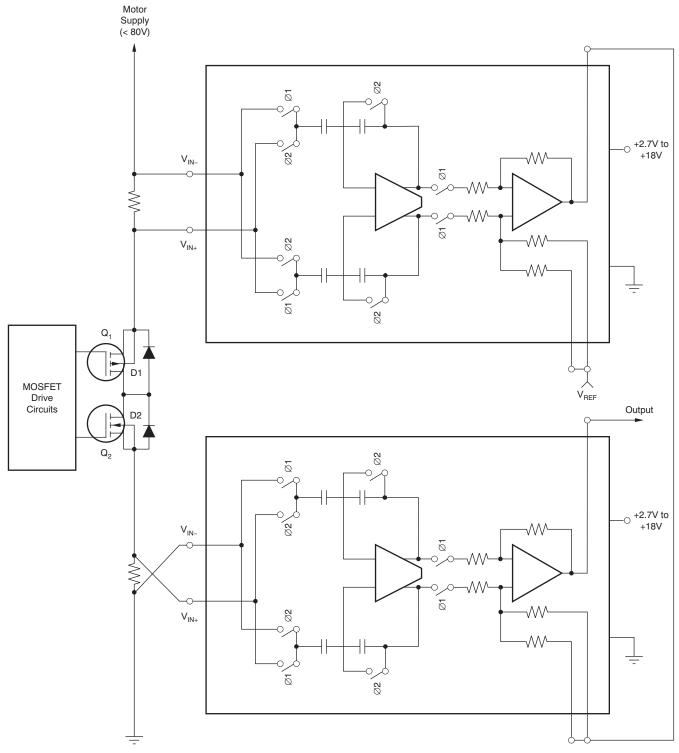


NOTE: Motor drive current sensing can be done on the low side, phase side, or high side. Only the phase output gives complete information regarding current in the motor, but is subject to common-mode transients that even the best amplifiers do not reject completely.

Figure 42. Motor Drive Current Sensing

However, sensing on the output is subject to large common-mode voltage steps that result in feedthrough in even the best amplifiers. The ground and supply-side sensing configurations are free of this problem, thanks to the static common-mode environments. Sensing either ground or supply alone only provides partial information regarding motor current, but sense them individually and sum them and we have the same information provided by phase sensing, with an added advantage of not being subject to transient common-mode artifacts. See Figure 43 for an illustration of two INA282 family devices connected in this manner. Technically, this configuration is current differencing, though, because we want the upper sense to report a positive-going excursion.





NOTE: By sensing totem-pole current on both the positive and negative rail and summing, dynamic common-mode issues can be avoided entirely. Note that IC₂ is connected with inverting inputs because it should report current with an opposite polarity to that of IC₁.

Figure 43. Sensing and Summing Totem Pole Current



PACKAGE OPTION ADDENDUM

5-Aug-2010

PACKAGING INFORMATION

www.ti.com

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
INA282AID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples
INA282AIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	Purchase Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

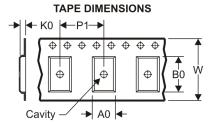
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 3-Aug-2010

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA282AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 3-Aug-2010

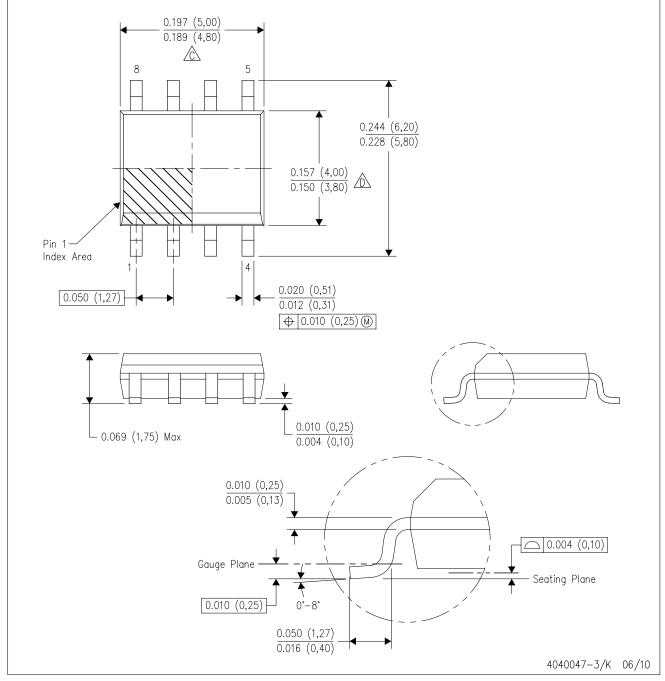


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
INA282AIDR	SOIC	D	8	2500	346.0	346.0	29.0

D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



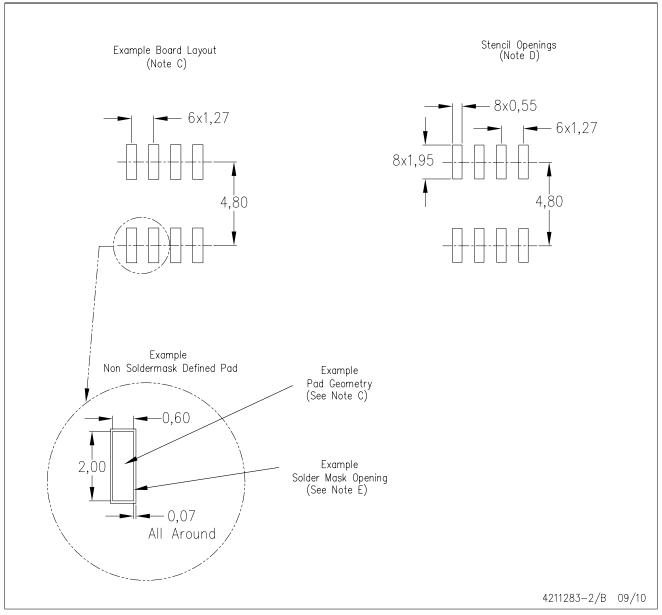
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AA.



D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DLP® Products	www.dlp.com	Communications and Telecom	www.ti.com/communications
DSP	<u>dsp.ti.com</u>	Computers and Peripherals	www.ti.com/computers
Clocks and Timers	www.ti.com/clocks	Consumer Electronics	www.ti.com/consumer-apps
Interface	interface.ti.com	Energy	www.ti.com/energy
Logic	logic.ti.com	Industrial	www.ti.com/industrial
Power Mgmt	power.ti.com	Medical	www.ti.com/medical
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
RFID	www.ti-rfid.com	Space, Avionics & Defense	www.ti.com/space-avionics-defense
RF/IF and ZigBee® Solutions	www.ti.com/lprf	Video and Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless-apps